

Low Loss IGBT in TrenchStop® and Fieldstop technology

- Very low $V_{CE(sat)}$ 1.5 V (typ.)
- Maximum Junction Temperature 175 °C
- Short circuit withstand time $5\mu s$
- Designed for :
 - Frequency Converters
 - Uninterrupted Power Supply
- TrenchStop[®] and Fieldstop technology for 600 V applications offers :
 - very tight parameter distribution
 - high ruggedness, temperature stable behavior
 - very high switching speed
- Positive temperature coefficient in V_{CE(sat)}
- Low EMI
- Low Gate Charge
- Qualified according to JEDEC¹ for target applications
- Pb-free lead plating; RoHS compliant
- Complete product spectrum and PSpice Models : <u>http://www.infineon.com/igbt/</u>

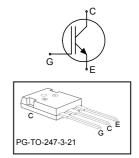
Туре	V _{CE}	I _c	V _{CE(sat), Tj=25°C}	T _{j,max}	Marking	Package
IGW75N60T	600V	75A	1.5V	175°C	G75T60	PG-TO-247-3-21

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V _{CE}	600	V
DC collector current, limited by T_{jmax}	I _C		А
$T_{\rm C} = 25^{\circ}{\rm C}$		150	
$T_{\rm C}$ = 100°C		75	
Pulsed collector current, t_p limited by T_{jmax}	I _{Cpuls}	225	
Turn off safe operating area ($V_{CE} \le 600V$, $T_j \le 175^{\circ}C$)	-	225	
Gate-emitter voltage	V _{GE}	±20	V
Short circuit withstand time ²⁾	t _{sc}	5	μs
V_{GE} = 15V, $V_{\text{CC}} \le 400$ V, $T_{j} \le 150^{\circ}$ C			
Power dissipation $T_{\rm C}$ = 25°C	P _{tot}	428	W
Operating junction temperature	Tj	-40+175	°C
Storage temperature	T _{stg}	-55+175	
Soldering temperature, 1.6mm (0.063 in.) from case for 10s	-	260	

¹J-STD-020 and JESD-022

²⁾ Allowed number of short circuits: <1000; time between short circuits: >1s.





TrenchStop[®] Series

Thermal Resistance

Parameter	Symbol	Conditions	Max. Value	Unit
Characteristic				•
IGBT thermal resistance,	R _{thJC}		0.35	K/W
junction – case				
Thermal resistance,	R _{thJA}		40	
junction – ambient				

Electrical Characteristic, at T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions		Value		Unit
Falameter	Symbol	Conditions	min.	Тур.	max.	
Static Characteristic						
Collector-emitter breakdown voltage	$V_{(BR)CES}$	V_{GE} =0V, I_{C} =0.2mA	600	-	-	V
Collector-emitter saturation voltage	$V_{CE(sat)}$	$V_{\rm GE}$ = 15V, $I_{\rm C}$ =75A				
		<i>T</i> _j =25°C	-	1.5	2.0	
		<i>T</i> _j =175°C	-	1.9	-	
Gate-emitter threshold voltage	V _{GE(th)}	$I_{\rm C}$ =1.2mA, $V_{\rm CE}$ = $V_{\rm GE}$	4.1	4.9	5.7	
Zero gate voltage collector current	I _{CES}	V _{CE} =600V, V _{GE} =0V				μA
		<i>T</i> _j =25°C	-	-	40	
		<i>T</i> _j =175°C	-	-	1000	
Gate-emitter leakage current	I _{GES}	$V_{\rm CE} = 0 V, V_{\rm GE} = 20 V$	-	-	100	nA
Transconductance	g fs	V _{CE} =20V, <i>I</i> _C =75A	-	41	-	S
Integrated gate resistor	R _{Gint}			-		Ω

Dynamic Characteristic

Input capacitance	Ciss	V _{CE} =25V,	-	4620	-	pF
Output capacitance	Coss	V _{GE} =0V,	-	288	-	
Reverse transfer capacitance	Crss	f=1MHz	-	137	-	
Gate charge	Q _{Gate}	$V_{\rm CC}$ =480V, $I_{\rm C}$ =75A	-	470	-	nC
		V _{GE} =15V				
Internal emitter inductance	LE		-	13	-	nH
measured 5mm (0.197 in.) from case						
Short circuit collector current ¹⁾	I _{C(SC)}	V_{GE} =15V, t_{SC} ≤5µs V_{CC} = 400V, T_{j} ≤ 150°C	-	687.5	-	A

¹⁾ Allowed number of short circuits: <1000; time between short circuits: >1s.



TrenchStop[®] Series

Switching Characteristic, Inductive Load, at Ti=25 °C

Parameter	Symbol	Conditions		Value		
Falametei	Symbol	Conditions	min.	Тур.	max.	Unit
IGBT Characteristic						
Turn-on delay time	t _{d(on)}	<i>T</i> _j =25°C, <i>V</i> _{CC} =400V, <i>I</i> _C =75A,	-	33	-	ns
Rise time	t _r	V _{CC} =400V, <i>I</i> _C =75A, V _{GE} =0/15V,	-	36	-	
Turn-off delay time	$t_{d(off)}$	$R_{\rm GE}=0/15V,$ $R_{\rm G}=5\Omega,$	-	330	-	
Fall time	t _f	$L_{\sigma}^{(2)} = 100 \text{ nH},$	-	35	-	
Turn-on energy ¹⁾	Eon	$C_{\sigma}^{(2)}$ =39pF	-	2.0	-	mJ
Turn-off energy	E _{off}	Energy losses include "tail" and diode	-	2.5	-	
Total switching energy	E _{ts}	reverse recovery.	-	4.5	-	

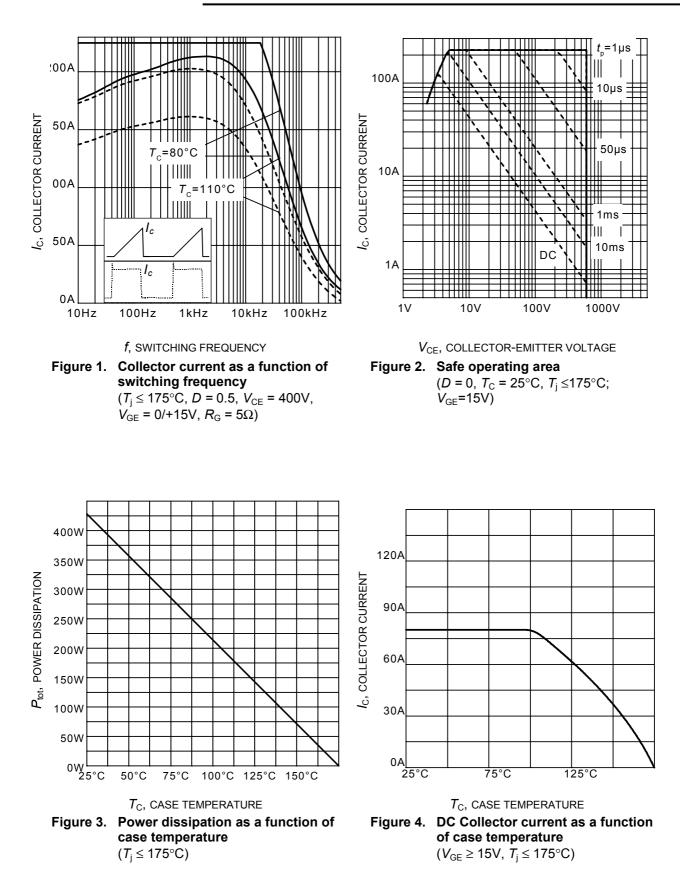
Switching Characteristic, Inductive Load, at T_i=175 °C

Parameter	Symbol	Conditions	Value			Unit
Falameter	Symbol	Conditions	min.	Тур.	max.	Unit
IGBT Characteristic						
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =175°C,	-	32	-	ns
Rise time	t _r	$V_{\rm CC}$ =400V, $I_{\rm C}$ =75A,	-	37	-	
Turn-off delay time	$t_{d(off)}$	V _{GE} =0/15V, R _G = 5Ω	-	363	-	
Fall time	t _f	$L_{\sigma}^{(2)} = 100 \text{nH},$	-	38	-	
Turn-on energy ¹⁾	Eon	$C_{\sigma}^{2)}$ =39pF	-	2.9	-	mJ
Turn-off energy	E _{off}	Energy losses include "tail" and diode	-	2.9	-	
Total switching energy	Ets	reverse recovery.	-	5.8	-	1

¹⁾ Includes Reverse Recovery Losses from IKW75N60T due to dynamic test circuit in Figure E. ²⁾ Leakage inductance L_{σ} and Stray capacity C_{σ} due to dynamic test circuit in Figure E.

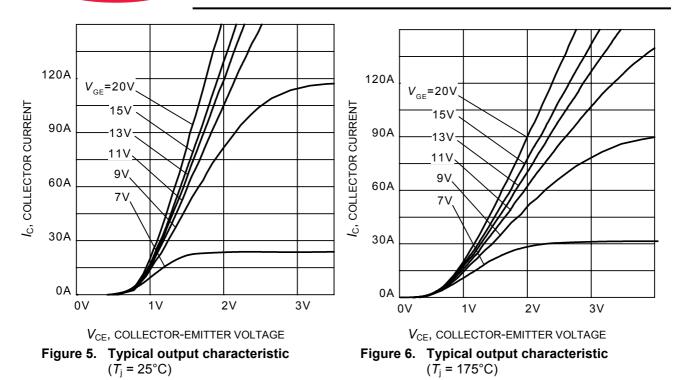


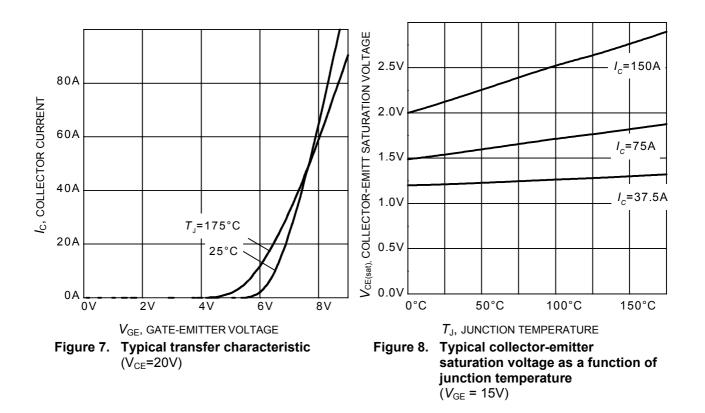
TrenchStop[®] Series





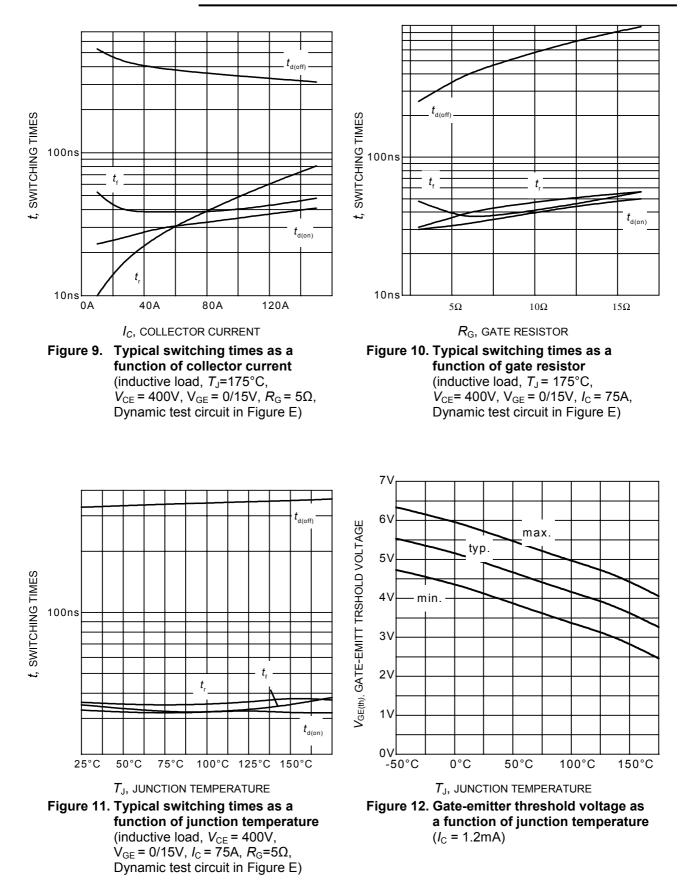
TrenchStop[®] Series





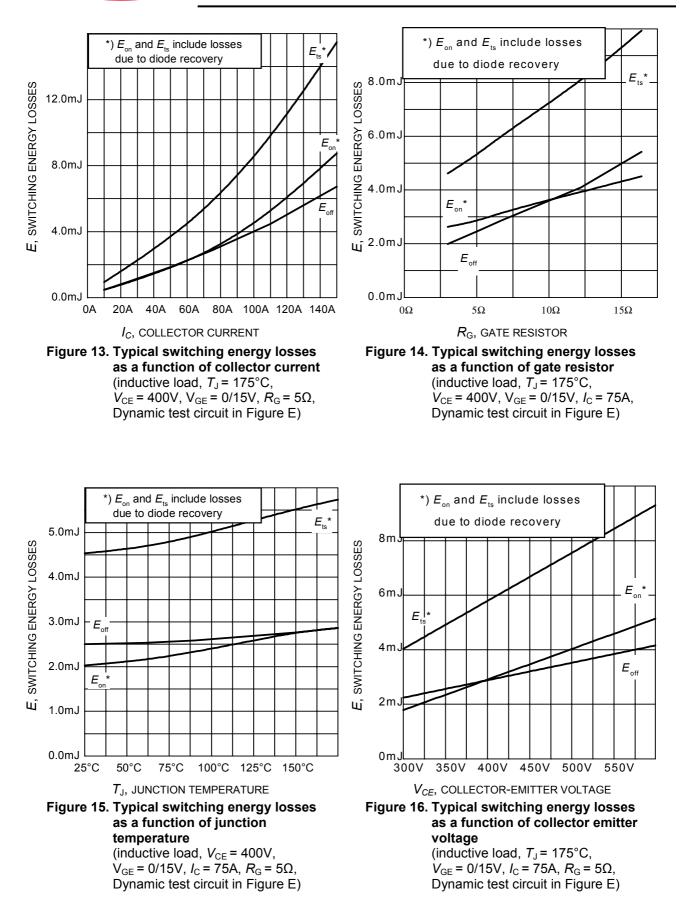


TrenchStop[®] Series



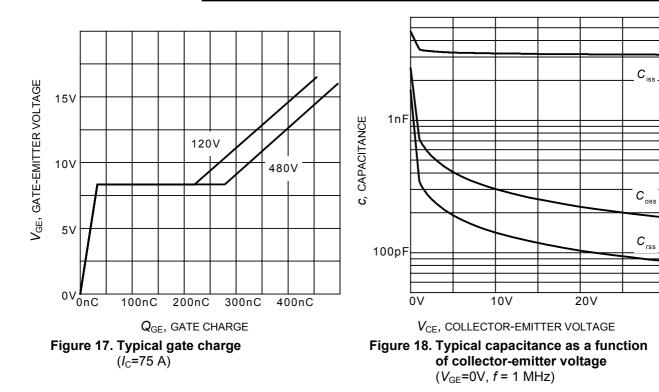


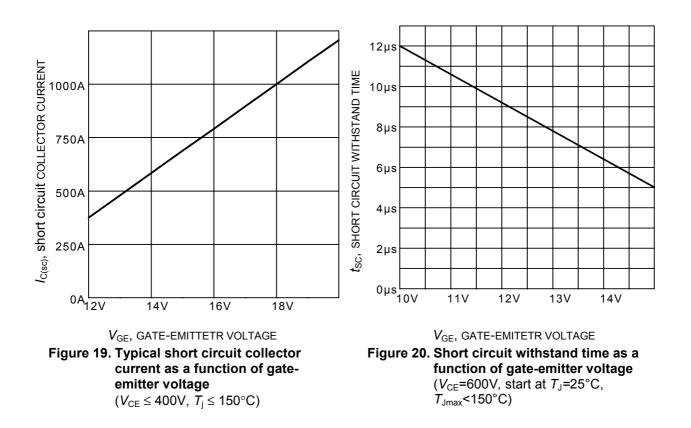
TrenchStop[®] Series





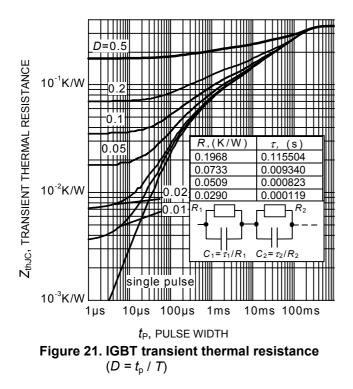
TrenchStop[®] Series

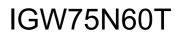






TrenchStop[®] Series



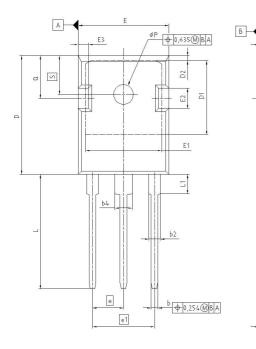




TrenchStop[®] Series

PG-TO247-3-21

A1



	MILLIME	TERS	INCH	IES
DIM	MIN	MAX	MIN	MAX
A	4.903	5.157	0.193	0.203
A1	2.273	2.527	0.092	0.096
A2	1.853	2.107	0.075	0.081
b	1.073	1.327	0.047	0.052
b2	1.903	2.386	0.075	0.094
b4	2.870	3.454	0.113	0.136
C	0.549	0.752	0.024	0.030
D	20.823	21.077	0.820	0.830
D1	17.323	17.831	0.682	0.702
D2	1.063	1.317	0.042	0.052
E	15.773	16.027	0.621	0.631
E1	13.893	14.147	0.547	0.557
E2	3.683	3.937	0.145	0.155
E3	1.683	1.937	0.066	0.076
е	5.4	50	0.2	215
e1	10.9	900	0.4	130
N	3	3		3
L	20.053	20.307	0.789	0.799
L1	4.168	4.472	0.164	0.176
øP	3.559	3.661	0.140	0.144
Q	5.493	5.747	0.216	0.226
S	6.043	6.297	0.238	0.248





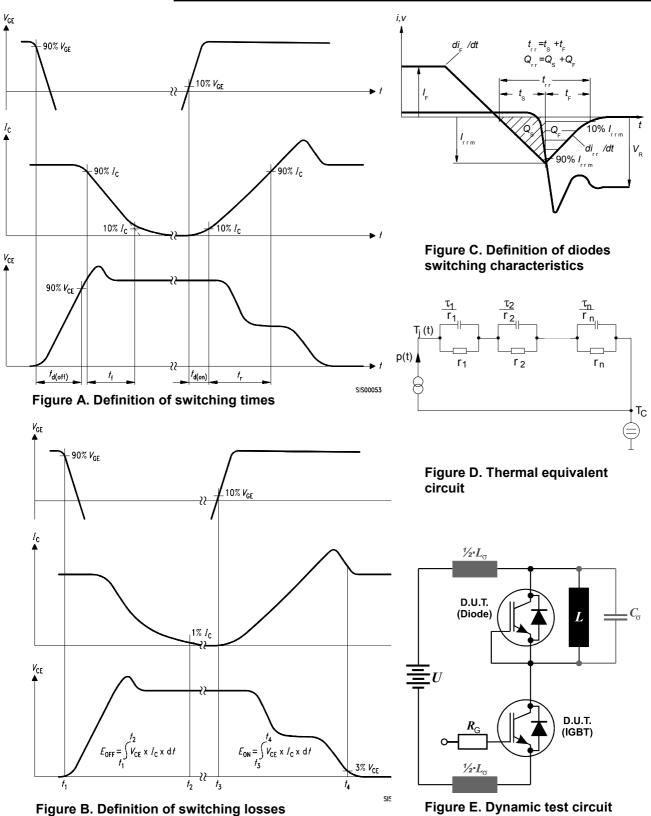


Figure E. Dynamic test circuit



Edition 2006-01

Published by Infineon Technologies AG 81726 München, Germany

© Infineon Technologies AG 11/3/06. All Rights Reserved.

Attention please!

The information given in this data sheet shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie"). With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office (**www.infineon.com**).

Warnings

Due to technical requirements components may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies Office.

Infineon Technologies Components may only be used in life-support devices or systems with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system, or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body, or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.